

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,716	DE MOL VAN OTTERLOO, MAARTEN JOOST	
Examiner	Art Unit	

Steven S. Paik

2876

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SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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Text search		
partially searched: cl. 235; 283; 399	9/29/2005	SSP
updated .	3/18/2006	SSP